

Search Notes

Application/Control No.

10/762,790

Examiner

Sun J. Lin

Applicant(s)/Patent under
Reexamination

ZHANG ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	4	12/5/2005	JSL
716	5	12/5/2005	JSL
716	6	12/5/2005	JSL
716	7	12/5/2005	JSL
716	8	12/5/2005	JSL
716	8	12/5/2005	JSL
716	10	12/5/2005	JSL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST [USPAT;US- PGPUB;EPO;JPO;DERWENT;IBM_T DB]	12/5/2005	JSL